

<b>Notice of References Cited</b>	Application/Control No. 10/609,192	Applicant(s)/Patent Under Reexamination TAN ET AL.	
	Examiner Jacob Cheu	Art Unit 1641	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,795,734	08-1998	Flanagan et al.	435/69.1
*	B	US-2003/0108869	06-2003	Michnick et al.	435/6
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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